SN54ALS03B, SN74ALS03B QUADRUPLE 2-INPUT POSITIVE-NAND BUFFERS WITH OPEN-COLLECTOR OUTPUTS

SDAS013B - MARCH 1984 - REVISED DECEMBER 1994

 Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

^Idescription

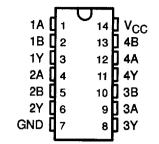
These devices contain four independent 2-input positive-NAND buffers. They perform the Boolean functions $Y = \overline{A \bullet B}$ or $Y = \overline{A} + \overline{B}$ in positive logic. The open-collector outputs require pullup resistors to perform correctly. These outputs may be connected to other open-collector outputs to implement active-low wired-OR or active-high wired-AND functions. Open-collector devices are often used to generate high V_{OH} levels.

The SN54ALS03B is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS03B is characterized for operation from 0°C to 70°C.

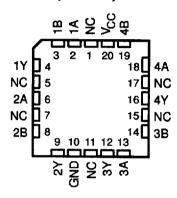
FUNCTION TABLE (each gate)

INP	UTS	OUTPUT
A	В	1 Y
Н	Н	L
L	X	Н
Χ	L	Н .

SN54ALS03B ... J PACKAGE SN74ALS03B ... D OR N PACKAGE (TOP VIEW)

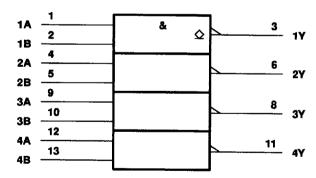


SN54ALS03B ... FK PACKAGE (TOP VIEW)



NC - No internal connection

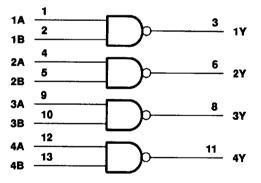
logic symbolt



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, J, and N packages.

logic diagram (positive logic)



PRODUCTION DATA Information is current as of publication date. Products conform to specifications per the terms of Texas instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC}	7 V
Input voltage, V _I	7 V
Off-state output voltage	7 V
Operating free-air temperature range, TA: SN54ALS03B	55°C to 125°C
SN74ALS03B	0°C to 70°C
Storage temperature range	65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

	· · · · · · · · · · · · · · · · · · ·	SN	SN54ALS03B			SN74ALS03B			
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	٧	
VIН	High-level input voltage	2			2			٧	
٧ _{IL}	Low-level input voltage			0.7			8.0	٧	
∨он	High-level output voltage			5.5			5.5	٧	
loL	Low-level output current			4			8	mΑ	
TA	Operating free-air temperature	-55		125	0		70	°C	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS03B			SN74ALS03B			
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT
۷ _{IK}	$V_{CC} = 4.5 V$,	i _l = -18 mA			-1.5			-1.5	٧
Vo	V _{CC} = 4.5 V	IOL = 4 mA		0.25	0.4		0.25	0.4	V
VOL		IOL = 8 mA					0.35	0.5	>
lj .	$V_{CC} = 5.5 V$,	V _I = 7 V			0.1			0.1	mΑ
ΊΗ	V _{CC} = 5.5 V,	V ₁ = 2.7 V			20			20	μΑ
IIL.	$V_{CC} = 5.5 V$,	V ₁ = 0.4 V			-0.1			-0.1	mΑ
ЮН	V _{CC} = 4.5 V,	V _{OH} = 5.5 V			0.1			0.1	mA
_I CCH	V _{CC} = 5.5 V,	V ₁ = 0		0.43	0.85		0.43	0.85	mΑ
CCL	V _{CC} = 5.5 V,	V _I = 4.5 V		1.62	3		1.62	4	mΑ

[‡] All typical values are at V_{CC} = 5 V, T_A = 25°C.

switching characteristics (see Figure 1)

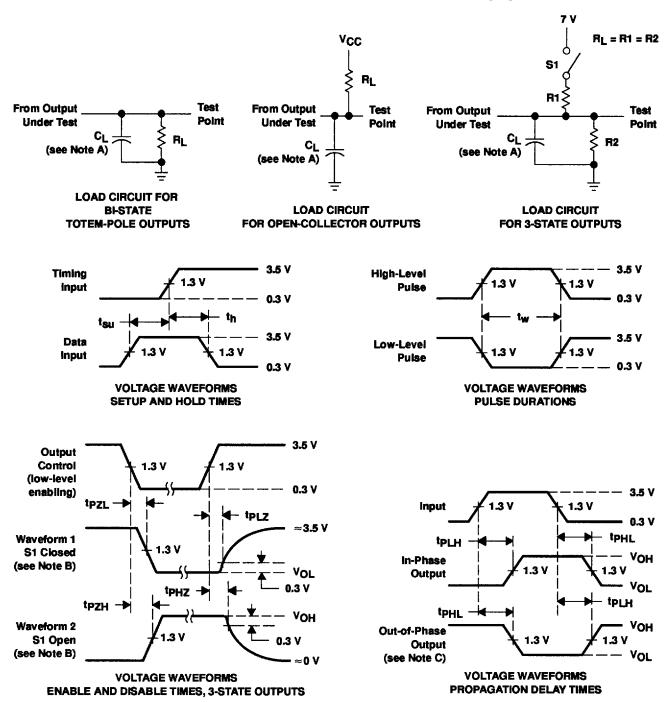
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _C C _L R _L T _A	UNIT			
			SN54ALS03B		SN74ALS03B		l
			MIN	MAX	MIN	MAX	
IPLH	A or B	Y	20	59	20	50	70
†PHL	ζ.		3	23	3	13	ns

[§] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



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PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. Ci includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR \leq 1 MHz, $t_r = t_f = 2$ ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms

